

### HM2302-VB Datasheet

## N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	<b>R<sub>DS(on)</sub> (</b> Ω <b>)</b>	I <sub>D</sub> (A) <sup>e</sup>	Q <sub>g</sub> (Typ.)			
	0.028 at V <sub>GS</sub> = 4.5 V	6 <sup>a</sup>				
20	0.042 at V <sub>GS</sub> = 2.5 V	6 <sup>a</sup>	8.8 nC			
	0.050 at V <sub>GS</sub> = 1.8 V	5.6				

SOT-23

3 D

G 1

S 2

#### FEATURES

- Halogen-free According to IEC 61249-2-21
   Definition
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- DC/DC Converters
- Load Switch for Portable Applications

Top View					
ABSOLUTE MAXIMUM RATIN	I <b>GS</b> T <sub>A</sub> = 25 °C,	unless otherwise	e noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	20	V	
Gate-Source Voltage		V <sub>GS</sub>	± 12	V	
	T <sub>C</sub> = 25 °C		6 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 70 °C		5.1		
Continuous Drain Current $(1) = 150^{\circ}$ C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	5 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		4 <sup>b, c</sup>	A	
Pulsed Drain Current	•	I <sub>DM</sub>	20		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		1.75		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	1.04 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		2.1		
Maximum Bower Dissipation	T <sub>C</sub> = 70 °C		1.3	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.25 <sup>b, c</sup>	vv	
	T <sub>A</sub> = 70 °C		0.8 <sup>b, c</sup>		
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	R <sub>thJA</sub>	80	100	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	40	60	C/W		

Notes:

a. Package limited

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 125 °C/W.

e. Based on T\_C = 25 °C.



FREE

$\begin{array}{ c c c c c c } \hline Parameter & Symbol & Test Conditions & Min. & Typ. & Max. & Unit \\ \hline Static & & & & & & & & & & & & & & & & & & &$	<b>SPECIFICATIONS</b> $T_J = 25 \text{ °C}$ , unless otherwise noted						
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Static						
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 µA	20			V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		25		m\//°C
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η - 200 μλ		- 2.6		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.45		1.0	V
	Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 100	nA
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		lana	$V_{DS} = 20 V, V_{GS} = 0 V$			1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gate Voltage Drain Current	DSS	$V_{DS}$ = 20 V, $V_{GS}$ = 0 V, $T_{J}$ = 70 °C			10	μΑ
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS}{\leq}5$ V, $V_{GS}{=}4.5$ V	20			A
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$			$V_{GS} = 4.5 \text{ V}, I_D = 5.0 \text{ A}$		0.028		
Forward Transconductance <sup>a</sup> $g_{fs}$ $V_{DS} = 10 \text{ V}, I_D = 5.0 \text{ A}$ 24SDynamic <sup>b</sup> Input Capacitance $C_{iss}$ $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ 865 $PF$	Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 2.5 \text{ V}, I_D = 4.7 \text{ A}$		0.042		Ω
Dynamic <sup>b</sup> 865           Input Capacitance         C <sub>iss</sub> Output Capacitance         C <sub>oss</sub> V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz         105		-	$V_{GS} = 1.8 \text{ V}, I_D = 4.3 \text{ A}$		0.050		
Input Capacitance         C <sub>iss</sub> 865           Output Capacitance         C <sub>oss</sub> V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz         105         pF	Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 5.0 \text{ A}$		24		S
Output Capacitance $C_{oss}$ $V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$ 105pF	Dynamic <sup>b</sup>				•	•	•
	Input Capacitance	C <sub>iss</sub>			865		
	Output Capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		105		pF
	Reverse Transfer Capacitance				55		
$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 5 \text{ V}, \text{ I}_{D} = 5.0 \text{ A}$ 12 18		0	$V_{DS} = 10 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 5.0 \text{ A}$		12	18	
Total Gate Charge $Q_g = \frac{V_{DS} - 10V, V_{GS} - 5V, I_D - 5.0 A}{8.8}$	Total Gate Charge	Qg			8.8	14	nC
Gate-Source Charge $Q_{gs}$ $V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 5.0 \text{ A}$ 1.1	Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 10$ V, $V_{GS} = 4.5$ V, $I_{D} = 5.0$ A		1.1		
Gate-Drain Charge Q <sub>gd</sub> 0.7	Gate-Drain Charge	Q <sub>gd</sub>			0.7		
Gate Resistance $R_g$ f = 1 MHz 0.5 2.4 4.8 $\Omega$	Gate Resistance	Rg	f = 1 MHz	0.5	2.4	4.8	Ω
Turn-On Delay Time t <sub>d(on)</sub> 8 16	Turn-On Delay Time	t <sub>d(on)</sub>			8	16	
Rise Time $t_r$ $V_{DD}$ = 10 V, $R_L$ = 2.2 $\Omega$ 17         26	Rise Time	t <sub>r</sub>	BB E		17	26	
Turn-Off Delay Time $t_{d(off)}$ $I_D \cong 4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ 3147	Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		31	47	1
Fall Timetf816ns	Fall Time				8	16	ns
Turn-On Delay Time t <sub>d(on)</sub> 5 10	Turn-On Delay Time	t <sub>d(on)</sub>			5	10	
Rise Time $t_r$ $V_{DD} = 10 \text{ V}, \text{ R}_L = 2.2 \Omega$ 13         20	Rise Time		55 5		13	20	-
Turn-Off Delay Time $t_{d(off)}$ $I_D \cong 4 \text{ A}, V_{GEN} = 5 \text{ V}, R_g = 1 \Omega$ 2132	Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 4 \text{ A}, V_{GEN} = 5 \text{ V}, R_g = 1 \Omega$		21	32	
Fall Time t <sub>f</sub> 6 12	Fall Time	t <sub>f</sub>			6	12	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode CurrentIs $T_C = 25 \ ^{\circ}C$ 1.75	Continuous Source-Drain Diode Current	ا <sub>S</sub>	T <sub>C</sub> = 25 °C			1.75	•
Pulse Diode Forward Current I <sub>SM</sub> A	Pulse Diode Forward Current	I <sub>SM</sub>				20	A
Body Diode Voltage         V <sub>SD</sub> I <sub>S</sub> = 4 A, V <sub>GS</sub> = 0 V         0.75         1.2         V	Body Diode Voltage	$V_{SD}$	$I_{S} = 4 A, V_{GS} = 0 V$		0.75	1.2	V
Body Diode Reverse Recovery Time     trr     12     20     ns	Body Diode Reverse Recovery Time	t <sub>rr</sub>			12	20	ns
Body Diode Reverse Recovery Charge $Q_{rr}$ $I_F = 4 \text{ A}, dl/dt = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ 510nC	Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 4.4 dl/dt = 100.4/up T = 25.00		5	10	nC
Reverse Recovery Fall Time t <sub>a</sub>	Reverse Recovery Fall Time	t <sub>a</sub>	$F = 4 A$ , ui/ui = 100 A/µs, $T_{\rm J} = 25 C$		7	T	
Reverse Recovery Rise Time t <sub>b</sub> 5	Reverse Recovery Rise Time	t <sub>b</sub>			5		ns

Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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- 55 °C

1.5

20

T<sub>C</sub> =

15

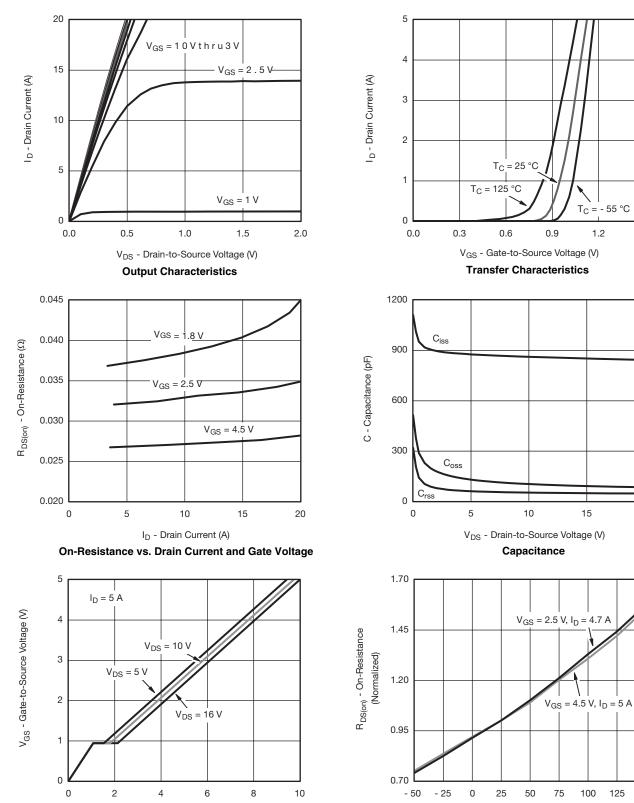
100

T<sub>J</sub> - Junction Temperature (°C)

**On-Resistance vs. Junction Temperature** 

125 150

1.2

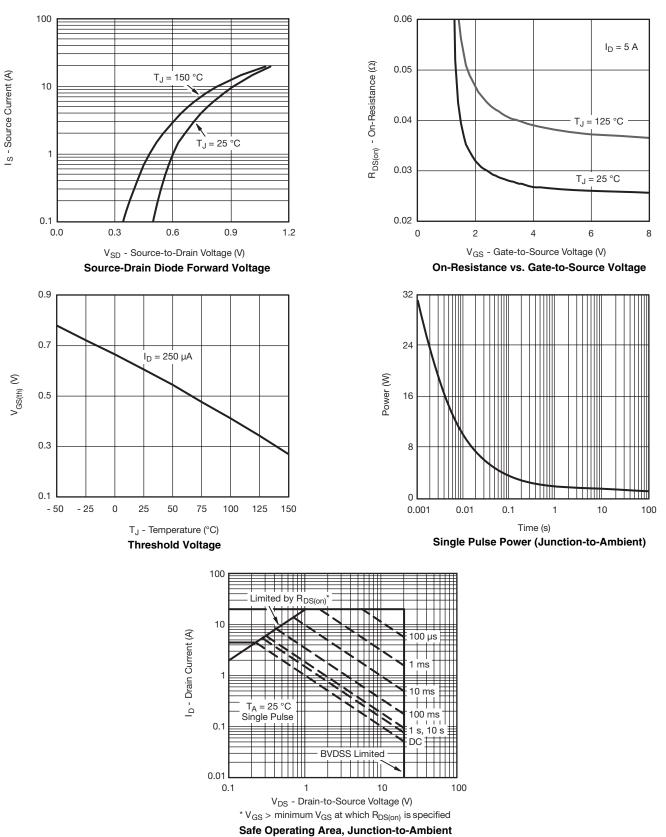


#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Q<sub>q</sub> - Total Gate Charge (nC)

**Gate Charge** 

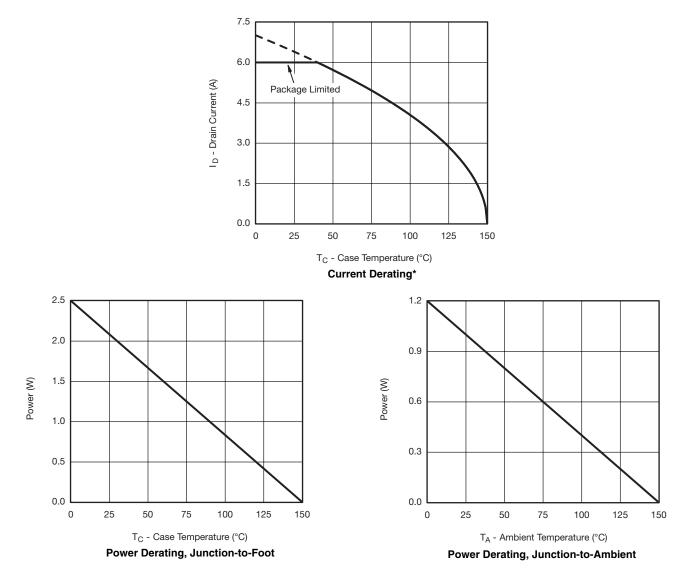




#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



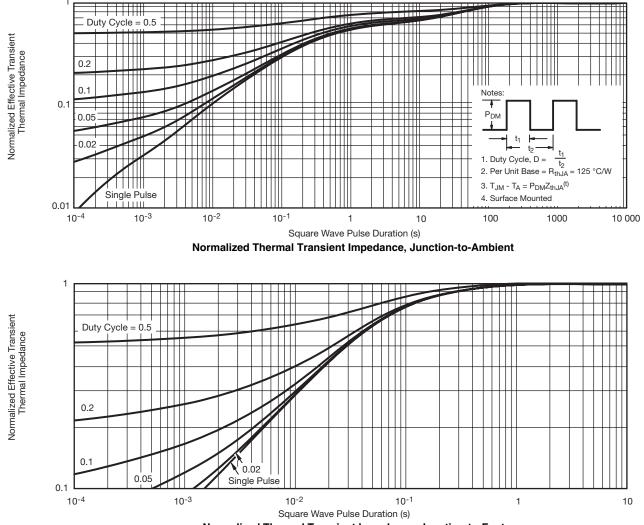
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







#### SOT-23 (TO-236): 3-LEAD



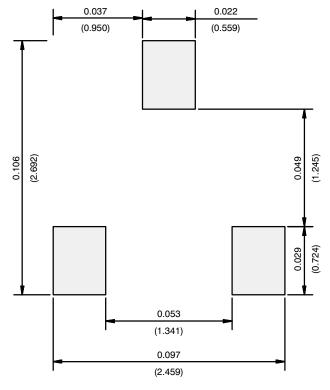




Dim	MILLIN	<b>IETERS</b>	INCHES			
	Min	Max	Min	Max		
Α	0.89	1.12	0.035	0.044		
A <sub>1</sub>	0.01	0.10	0.0004	0.004		
A <sub>2</sub>	0.88	1.02	0.0346	0.040		
b	0.35	0.50	0.014	0.020		
С	0.085	0.18	0.003	0.007		
D	2.80	3.04	0.110	0.120		
E	2.10	2.64	0.083	0.104		
E <sub>1</sub>	1.20	1.40	0.047	0.055		
е	0.95 BSC		0.0374 Ref			
e <sub>1</sub>	1.90 BSC		0.0748 Ref			
L	0.40	0.60	0.016	0.024		
L <sub>1</sub>	0.64 Ref		0.025	0.055 Ref Ref 0.024		
S	0.50 Ref		0.020	0.020 Ref		
q	3°	8°	3°	8°		
ECN: S-03946-Rev. K, 09- DWG: 5479	Jul-01					



#### **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)



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